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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/561,958	KWON, YONG-DUK	
Examiner	Art Unit	
David M. Brunsman	1755	

	SEARCHED		
Class	Subclass	Date	Examiner
106	126.2	9/22/2006	DB
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INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
eDan inventor name search	9/22/2006	DB
EAST text search - see prinout	9/22/2006	DB
PGPUBS interference search - see printout	9/22/2006	DB
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